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Certified Reference Material

Certificate of Analysis

ISO 17034:2016

ISO/IEC 17025:2017



Product ID: MBH-12X 15260 X

Product Description: Low Alloy Steel (Wrought)

Description and Intended Use: This **Certified Reference Material** is covered under the scope of accreditation to **ISO 17034** by LGC Standards - Manchester, NH. As an ISO 17034 certified reference material, appropriate use of this material will fulfill the certified reference material and traceability requirements for use in **ISO 17025** accredited laboratories. This CRM may come in the form of a solid disk, or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

.,				C	ertified Va	lues listed in	wt.%	with as	sociated u	ıncertainties				
Αl	0.5	57	± 0.01	As	0.044	± 0.002		С	0.404	± 0.008		Co	0.085	± 0.003
Cr	2.4	18	± 0.03	Cu	0.119	± 0.003		Mn	1.67	± 0.02		Мо	0.093	± 0.003
Nb	0.1	83	± 0.006	Ni	0.499	± 0.005		Р	0.034	± 0.001		Pb	0.0012	± 0.0004
S	0.0)86	± 0.006	Si	0.390	± 0.009		Sn	0.0021	± 0.0004		Ti	0.0064	± 0.0008
٧	0.4	117	± 0.003	Zr	0.0054	± 0.0005								
						Indicative	e Val	lues list	ed in ppm]				
	В	(<10) Ca	(<10)	Fe	(<94%)	N	(<220)	0	(<20)	Sb	(60)	Ta	(140)
	W	(30)	Zn	(<40)										

Homogeneity and Uncertainty: "Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where N_{prod} is the number of units produced and N_{min} is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculated uncertainty due to inhomogeneity (U_{hom}). Uncertainty of the material is calculated by equation 2, where H=U_{hom}, S= Standard deviation, t= t-value at 95% CI, and n= number of observations.

1.
$$N_{MIN} = \max(10, \sqrt[3]{N_{PROD}})$$
 2. $U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$

Certification Laboratories: Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials. Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

- LGC Standards Manchester, NH
- · Connecticut Metallurgical, Inc. East Hartford, CT
- NSL Analytical Services Cleveland, OH
- SGS MSi Melrose Park, IL
- IMR Test Labs Lansing, NY
- Laboratory Testing, Inc. Hatfield, PA
- Cleveland Cliffs Middletown, OH
- Applied Technical Services Marietta, GA
- EAG Laboratories Liverpool, NY
 Sheffield Assay Office Sheffield, UK
- Scrooby's Laboratory Service Rynfield, South Africa
- Element Materials Technology Middlesbrough, UK
- New Hampshire Materials Laboratory Somersworth, NH
- RSML Bengaluru, India

Instructions for Use: The test surface is on the opposite side of the labeled surface, which includes the material identification. This material is individually chill cast per piece. This manner of casting can cause the formation of inhomogeneous segregates in the upper, engraved portion of the disk. Therefore, the certification information above is not applicable to within 3mm of the engraved surface. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use. Chips are not recommended for gas analysis.

Period of Validity: The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

Kimberly Halkiotis, Global Product Manager

February 7, 2022 Certification Date



ISO 17034 Accredited: Reference Materials Producer, Certificate # 2848.02 ISO/IEC 17025 Accredited: Chemical Testing, Certificate # 2848.01



The following data represents all pertinent information reported as it applies to the chemical characterization of this material.

Lab	Al	As	В	С	Ca	Co	Cr	Cu	Fe	Mn	Мо	N	Nb	Ni
1	0.5208	0.0396	0.0003	0.3680	0.0002	0.0731	2.3610	0.1070	93.043	1.5370	0.0740	0.0212	0.1580	0.4840
2	0.5230	0.0405	0.0011	0.3805	<0.001	0.0758	2.3640	0.1076	94.850	1.5580	0.0797	0.0220	0.1600	0.4859
3	0.5290	0.0410	<0.001	0.3917		0.0770	2.4000	0.1100		1.6186	0.0820		0.1660	0.4870
4	0.5360	0.0410		0.3920		0.0790	2.4041	0.1150		1.6360	0.0875		0.1670	0.4893
5	0.5410	0.0434		0.4000		0.0810	2.4110	0.1168		1.6370	0.0890		0.1750	0.4910
6	0.5410	0.0435		0.4002		0.0830	2.4280	0.1180		1.6400	0.0890		0.1770	0.4940
7	0.5440	0.0435		0.4010		0.0830	2.4364	0.1187		1.6490	0.0920		0.1782	0.4940
8	0.5548	0.0450		0.4020		0.0836	2.4600	0.1190		1.6490	0.0920		0.1799	0.4958
9	0.5569	0.0450		0.4040		0.0840	2.4733	0.1190		1.6616	0.0921		0.1806	0.4960
10	0.5679	0.0450		0.4040		0.0840	2.4747	0.1196		1.6665	0.0930		0.1830	0.4961
11	0.5695	0.0460		0.4060		0.0849	2.4899	0.1205		1.6669	0.0930		0.1840	0.4990
12	0.5700	0.0460		0.4070		0.0853	2.4900	0.1210		1.6697	0.0940		0.1868	0.5010
13	0.5703	0.0469		0.4070		0.0854	2.4990	0.1211		1.6810	0.0950		0.1870	0.5010
14	0.5740	0.0493		0.4200		0.0866	2.5020	0.1214		1.6833	0.0950		0.1880	0.5025
15	0.5770			0.4210		0.0870	2.5090	0.1220		1.6890	0.0961		0.1890	0.5110
16	0.5797			0.4213		0.0892	2.5108	0.1220		1.6970	0.0967		0.1890	0.5150
17	0.5890			0.4390		0.0910	2.5120	0.1230		1.7120	0.0990		0.1914	0.5177
18	0.5930					0.0944	2.5600	0.1250		1.7143	0.1006		0.1927	0.5190
19	0.5947					0.1000	2.5740	0.1306		1.7240	0.1006		0.1930	
20	0.5960						2.5950	0.1320		1.7420	0.1011		0.2030	
21	0.6085						2.6280			1.7610	0.1014		0.2060	
22	0.6100													
Mean	0.5657	0.0440	0.0007	0.4038	0.0002	0.0846	2.4801	0.1195	93.947	1.6663	0.0925	0.0216	0.1826	0.4988
STDV	0.0269	0.0027	0.0006	0.0164		0.0063	0.0721	0.0063	1.2775	0.0539	0.0072	0.0006	0.0126	0.0107
Certified	0.57	0.044	(<0.001)	0.404	(<0.001)	0.085	2.48	0.119	(<94)	1.67	0.093	(<0.022)	0.183	0.499
Ucrm	0.01	0.002		0.008		0.003	0.03	0.003		0.02	0.003		0.006	0.005
Methods	I,O,G,X	IM,X,O,I	1,0	C,G,O	O,I	I,O,G,IM,X	I,G,O,X,W	I,O,IM,X	0	I,O,G,X	I,O,IM,X	F	I,O,G,IM,X	O,G,I,X

Lab	0	Р	Pb	S	Sb	Si	Sn	Та	Ti	٧	W	Zn	Zr
1	0.0013	0.0290	0.0007	0.0670	0.0004	0.3550	0.0010	0.0015	0.0034	0.4041	0.0003	0.0025	0.0041
2	0.0023	0.0293	0.0010	0.0750	0.0018	0.3580	0.0014	0.0060	0.0040	0.4090	0.0004	0.0036	0.0045
3		0.0310	0.0011	0.0750	0.0018	0.3650	0.0014	0.0108	0.0042	0.4130	0.0008	0.0070	0.0046
4		0.0313	0.0011	0.0767	0.0019	0.3730	0.0016	0.0108	0.0048	0.4130	0.0020		0.0047
5		0.0320	0.0011	0.0790	0.0040	0.3740	0.0018	0.0140	0.0050	0.4144	0.0020		0.0050
6		0.0325	0.0012	0.0800	0.0043	0.3773	0.0018	0.0147	0.0050	0.4150	0.0030		0.0051
7		0.0329	0.0015	0.0811	0.0050	0.3900	0.0020	0.0150	0.0050	0.4160	0.0041		0.0053
8		0.0331	0.0017	0.0823	0.0180	0.3910	0.0020	0.0151	0.0052	0.4170	0.0050		0.0055
9		0.0340	0.0017	0.0830	0.0194	0.3930	0.0023	0.0158	0.0060	0.4180	0.0050		0.0055
10		0.0350	< 0.002	0.0835	<0.0005	0.3982	0.0024	0.0185	0.0067	0.4187	0.0060		0.0060
11		0.0350	< 0.005	0.0840	<0.0010	0.3982	0.0026	0.0280	0.0068	0.4190	<0.0005		0.0060
12		0.0352		0.0860	< 0.002	0.4002	0.0027	<0.0020	0.0070	0.4190	<0.001		0.0060
13		0.0355		0.0900		0.4020	0.0029		0.0070	0.4200	<0.001		0.0065
14		0.0356		0.0953		0.4043	0.0030		0.0073	0.4216	<0.001		0.0067
15		0.0356		0.0960		0.4080	0.0030		0.0080	0.4216	< 0.001		<0.005
16		0.0359		0.0990		0.4090	<0.002		0.0080	0.4220	<0.0010		
17		0.0360		0.0990		0.4090	<0.002		0.0080	0.4255	<0.0010		
18		0.0370		0.1080		0.4096	<0.002		0.0080	0.4270	<0.005		
19		0.0380					<0.002		0.0080		<0.010		
20		0.0390					<0.005		0.0097				
21									<0.002				
22									<0.005				
Mean	0.0018	0.0341	0.0012	0.0856	0.0063	0.3897	0.0021	0.0137	0.0064	0.4174	0.0029	0.0044	0.0054
STDV	0.0007	0.0027	0.0003	0.0104	0.0072	0.0182	0.0006	0.0068	0.0017	0.0056	0.0021	0.0023	0.0008
Certified	(<0.002)	0.034	0.0012	0.086	(0.006)	0.390	0.0021	(0.014)	0.0064	0.417	(0.003)	(<0.004)	0.0054
UCRM		0.001	0.0004	0.006		0.009	0.0004		0.0008	0.003			0.0005
Methods	F	I,IM,G,O,X	IM,O,I	C,G,I,O,X	IM,X,O,I	I,G,IM,O,W,X	I,IM,O,X	I,IM,O	I,IM,G,O,X	I,G,IM,O,X	IM,I,G,O,X	IM,I	I,IM,X,O

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES